## **MOSFET** – Power, Single, N-Channel, SO-8 FL 30 V, 246 A

### Features

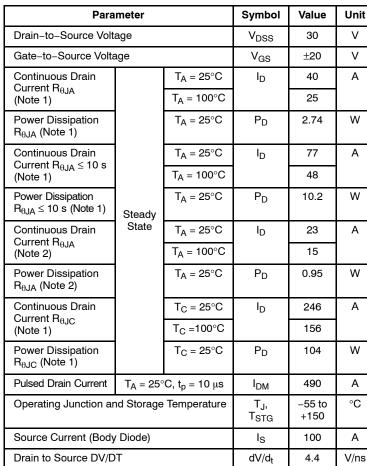
- Low R<sub>DS(on)</sub> to Improve Conduction and Overall Efficiency
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

### Applications

- OR-ing FET, Power Load Switch, Motor Control
- Refer to Application Note AND8195/D for Mounting Information

### **End Products**

• Motor Control, UPS, Fault-Tolerant Power Systems, Hot Swap



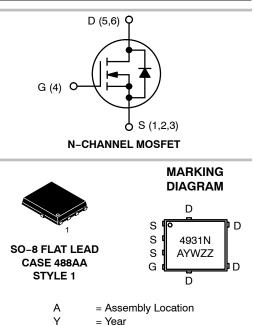
#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)



### **ON Semiconductor®**

### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
30 V	1.1 mΩ @ 10 V	246 A
50 V	1.5 mΩ @ 4.5 V	240 A



#### **ORDERING INFORMATION**

= Work Week

= Lot Traceability

w

77

Device	Package	Shipping <sup>†</sup>
NTMFS4931NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel
NTMFS4931NT3G	SO-8 FL (Pb-Free)	5000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, V <sub>DD</sub> = 24 V, V <sub>GS</sub> = 10 V, I <sub>L</sub> = 41 A <sub>pk</sub> , L = 0.3 mH, R <sub>G</sub> = 25 $\Omega$ )	E <sub>AS</sub>	252	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
2. Surface-mounted on FR4 board using the minimum recommended pad size.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	1.2	
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	45.7	°C/W
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	132	°C/W
Junction-to-Ambient – (t $\leq$ 10 s) (Note 3)	$R_{ hetaJA}$	12.3	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

#### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS						-	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> =	250 μΑ	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				18		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1.0	
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			15	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS}$ = 0 V, $V_{GS}$ = ±20 V				±100	nA
ON CHARACTERISTICS (Note 5)						-	-
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS}$ = $V_{DS}$ , $I_D$ = 250 $\mu$ A		1.2	1.6	2.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	R <sub>DS(on)</sub> V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		0.85	1.1	
			I <sub>D</sub> = 15 A		0.82		
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		1.2	1.5	mΩ
			I <sub>D</sub> = 15 A		1.2		
Forward Transconductance	<b>9</b> FS	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A			86		S

Input Capacitance	C <sub>ISS</sub>		9821	
Output Capacitance	C <sub>OSS</sub>	$V_{GS}$ = 0 V, f = 1 MHz, $V_{DS}$ = 15 V	2720	pF
Reverse Transfer Capacitance	C <sub>RSS</sub>		234	
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A	61.5	
Threshold Gate Charge	Q <sub>G(TH)</sub>		14.2	nC
Gate-to-Source Charge	Q <sub>GS</sub>	$v_{GS} = 4.5 v, v_{DS} = 15 v; i_D = 30 A$	25.2	nc
Gate-to-Drain Charge	Q <sub>GD</sub>		15.9	
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V; $I_D$ = 30 A	128	nC

### SWITCHING CHARACTERISTICS (Note 6)

Turn-On Delay Time	t <sub>d(ON)</sub>		27	
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V,	29	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_{\rm D}$ = 15 A, R <sub>G</sub> = 3.0 $\Omega$	36	ns
Fall Time	t <sub>f</sub>		24	

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

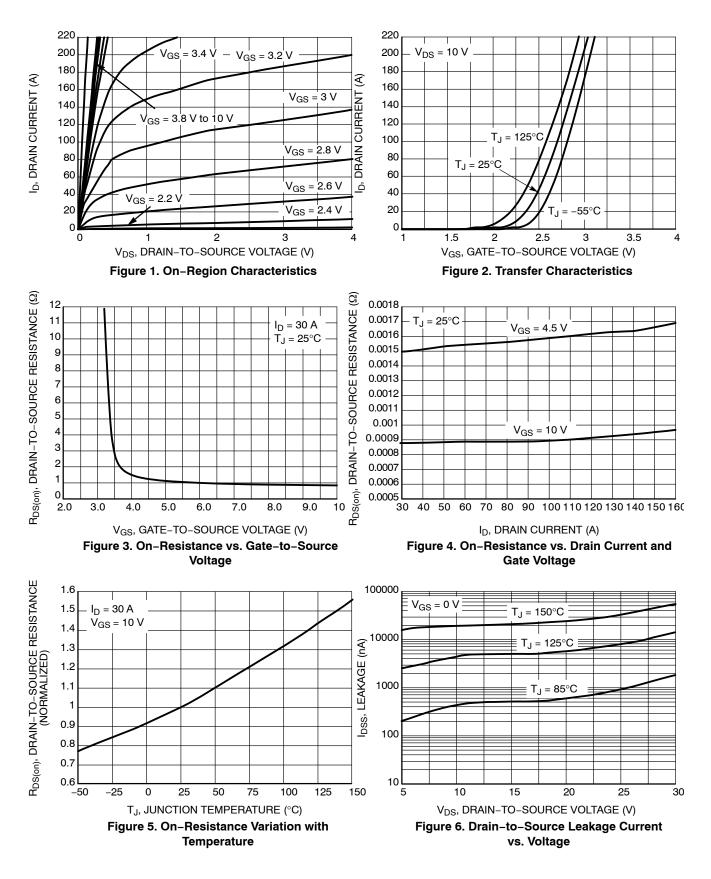
### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 6)						
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, I <sub>D</sub> = 15 A, R <sub>G</sub> = 3.0 $\Omega$			15		_
Rise Time	t <sub>r</sub>				17		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_{\rm D} = 15 \rm A,  R_{\rm C}$	<sub>a</sub> = 3.0 Ω		80		ns ns
Fall Time	t <sub>f</sub>				22		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V <sub>SD</sub>	SD $V_{GS} = 0 V$ , $T_J = 25^{\circ}C$ $I_S = 30 A$ $T_J = 125^{\circ}C$		0.8	1.0	v	
			T <sub>J</sub> = 125°C		0.62		v
Reverse Recovery Time	t <sub>RR</sub>				64		
Charge Time	t <sub>a</sub>	V <sub>GS</sub> = 0 V, dIS/d	t = 100 A/μs,		33		ns
Discharge Time	t <sub>b</sub>	I <sub>S</sub> = 30 A			31		
Reverse Recovery Charge	Q <sub>RR</sub>				100		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>				0.50		nH
Drain Inductance	L <sub>D</sub>	− T <sub>A</sub> = 25°C			0.005		nH
Gate Inductance	L <sub>G</sub>				1.84		nH
Gate Resistance	R <sub>G</sub>				0.7	1.8	Ω

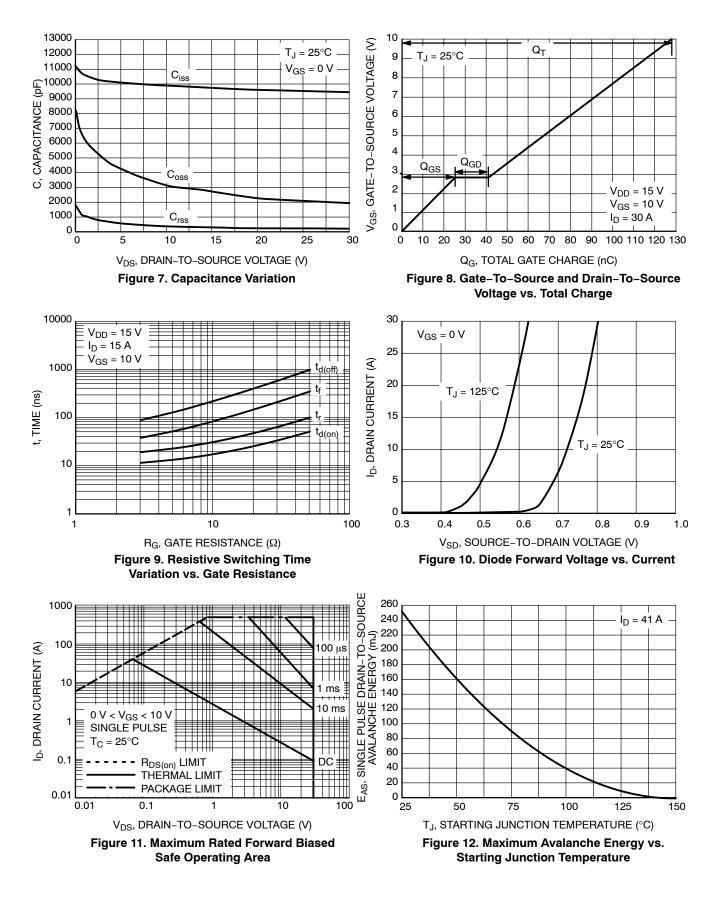
5. Pulse Test: pulse width  $\leq$  300 µs, duty cycle  $\leq$  2%. 6. Switching characteristics are independent of operating junction temperatures.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

### **TYPICAL CHARACTERISTICS**



### **TYPICAL CHARACTERISTICS**



### **TYPICAL CHARACTERISTICS**

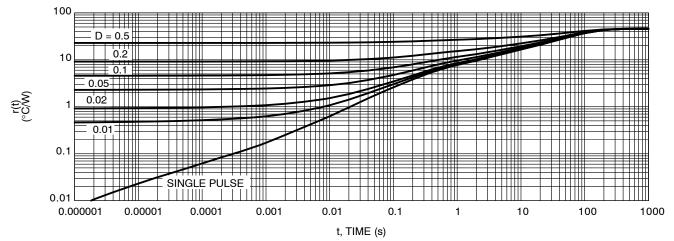
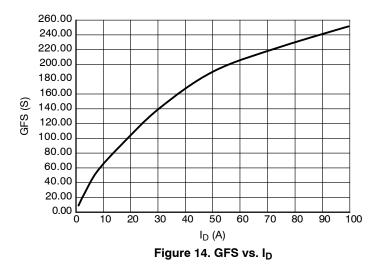
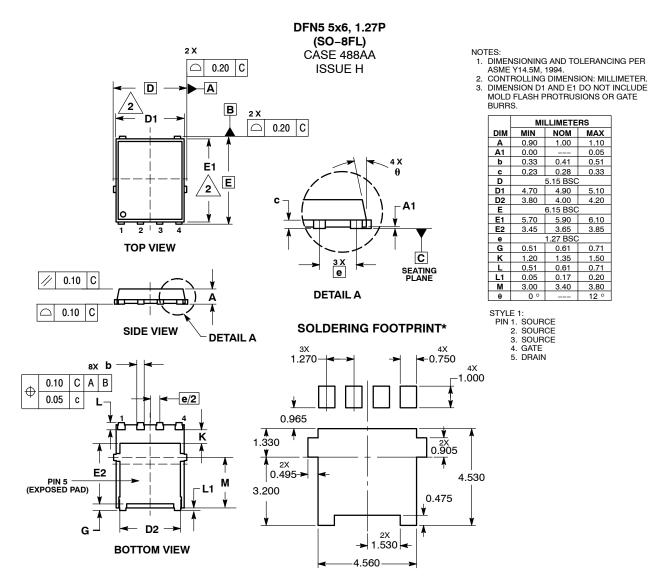


Figure 13. Thermal Response



#### PACKAGE DIMENSIONS



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor roducts, "including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor." "Typical" parameters which may be provided in ON Semiconductor dates thesets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights or the rights of others. ON Semiconductor and is officers, employees or use ON Semiconductor products for any such unintended or inauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly, any claim of personal injury or death associated with such unintended or unauthorized application. Buyer shall indemnify and hold ON

#### PUBLICATION ORDERING INFORMATION

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support:

Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative